

UNISONIC TECHNOLOGIES CO., LTD

2NM65-V **Preliminary Power MOSFET**

2.0A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

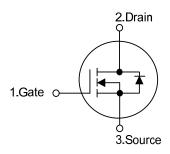
DESCRIPTION

The UTC 2NM65-V is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at AC-DC converters for power applications.

FEATURES

- * $R_{DS(ON)} \le 3.0 \Omega @ V_{GS} = 10V, I_D = 1.0A$ $R_{DS(ON)} \le 3.5 \Omega @ V_{GS}=4.5V, I_D=1.0A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL

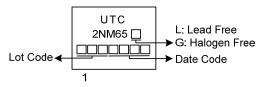


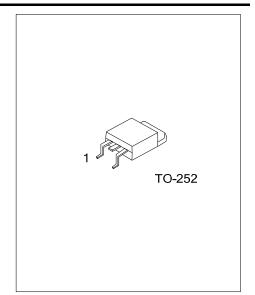
ORDERING INFORMATION

	Ordering Number		Daaltana	Pin Assignment			Da alsima	
	Lead Free	Halogen Free	Package	1	2	3	Packing	
Ī	2NM65L-TN3-R	2NM65G-TN3-R	TO-252	G	D	S	Tape Reel	
Ī	Note: Pin Assignment: G: Gate D: Drain S: Source							

2NM65G-TN3-R (1) R: Tape Reel (1)Packing Type (2)Package Type (2) TN3: TO-252 (3)Green Package (3) G: Halogen Free and Lead Free, L: Lead Free

MARKING





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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	650	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Danie Coment	Continuous	I _D	2	Α	
Drain Current	Pulsed (Note 2)	I _{DM}	4	Α	
Avalanche Energy (Note 3)	valanche Energy (Note 3) Single Pulsed		42	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	2	V/ns	
Power Dissipation		P _D	20	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 100mH, I_{AS} = 0.92A, V_{DD} = 80V, R_G = 25 Ω Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 2.0 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25 ^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θις	6.25 (Note)	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

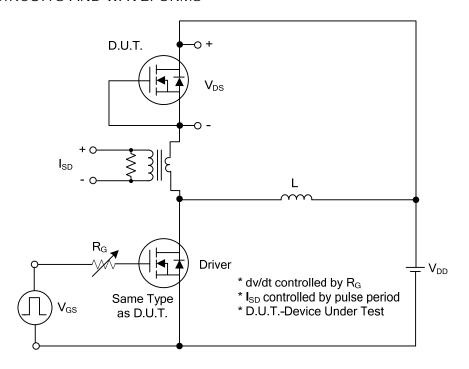
■ ELECTRICAL CHARACTERISTICS (T」=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_DSS	V _{GS} =0V, I _D =250μA	650			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =650V, V _{GS} =0V			10	μΑ
Cata Carraga Laghaga Crimant	Forward	I _{GSS}	V _{GS} =30V, V _{DS} =0V			100	nA
Gate-Source Leakage Current	Reverse		V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.0		3.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =1.0A			3.0	Ω
			V _{GS} =4.5V, I _D =1.0A			3.5	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}			155		pF
Output Capacitance		Coss	$V_{GS} = 0V$, $V_{DS} = 50V$, $f = 1MHz$		22		pF
Reverse Transfer Capacitance		C _{RSS}			2.3		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge (Note 1)		Q_G	\/ -E20\/ \/ -10\/ -1 0A		16		nC
Gate-Source Charge		Q_{GS}	V _{DS} =520V, V _{GS} =10V, I _D =1.0A (Note 1, 2)		3.6		nC
Gate-Drain Charge		Q_{GD}	(Note 1, 2)		3		nC
Turn-On Delay Time (Note 1)		t _{D (ON)}	-400 -40		4		ns
Turn-On Rise Time		t _R	V _{DS} =100V, V _{GS} =10V,		17.5		ns
Turn-Off Delay Time		$t_{D(OFF)}$	I _D =1.0A, R _G =25Ω (Note 1, 2)		30		ns
Turn-Off Fall Time		t _F	(Note 1, 2)		40		ns
DRAIN-SOURCE DIODE CHARAC	CTERISTICS						
Continuous Drain-Source Current		Is				2	Α
Maximum Body-Diode Pulsed Current		I _{SM}				4	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =2.0A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =2.0A, V _{GS} =0V		160		nS
Body Diode Reverse Recovery Charge		Qrr	dl/dt=100A/µs		0.55		μC

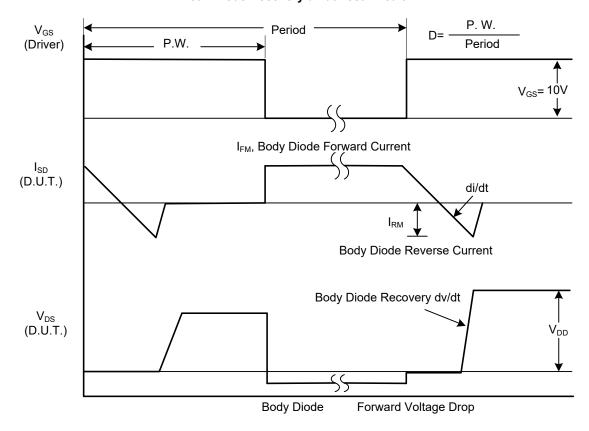
Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

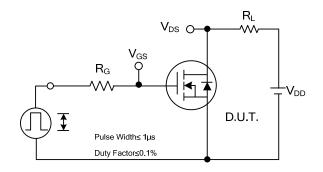


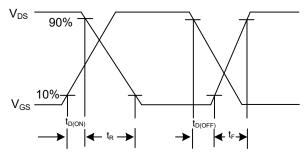
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

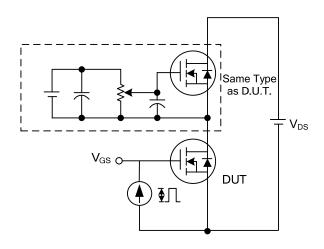
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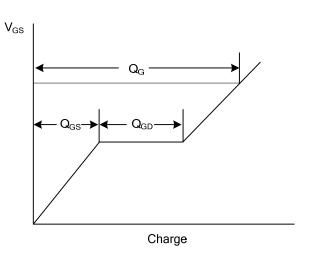




Switching Test Circuit

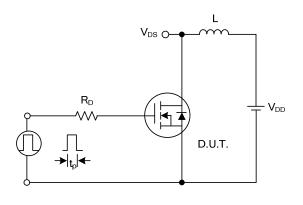
Switching Waveforms

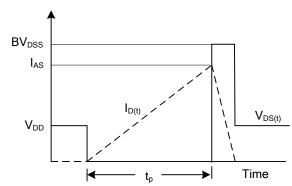




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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